


<b>Search Notes</b> 	<b>Application/Control No.</b> 10553931	<b>Applicant(s)/Patent Under Reexamination</b> BAYLISS ET AL.
	<b>Examiner</b> BENJAMIN P LEE	<b>Art Unit</b> 3641

SEARCHED			
Class	Subclass	Date	Examiner
102	275.1	1/15/2010	LEE
102	277.1	1/15/2010	LEE
102	275.8	1/15/2010	LEE
102	275.9	1/15/2010	LEE
102	275.2	1/15/2010	LEE
102	275.3	1/15/2010	LEE
102	275.4	1/15/2010	LEE

SEARCH NOTES		
Search Notes	Date	Examiner
Text search	1/15/2010	LEE
Inventor search	1/15/2010	LEE
updated search	10/23/2010	LEE
updated search		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
102	275.1	9/8/2011	LEE
102	277.1	9/8/2011	LEE
102	275.8	9/8/2011	LEE
102	275.9	9/8/2011	LEE
102	275.2	9/8/2011	LEE
102	275.3	9/8/2011	LEE
102	275.4	9/8/2011	LEE

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